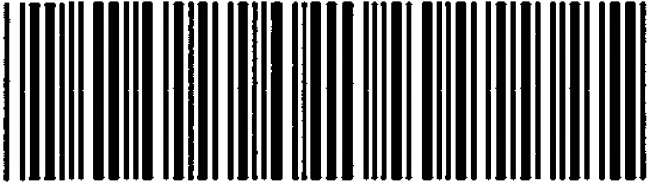


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/823,581	CHEN ET AL.	
	Examiner	Art Unit	
	Scott L. Jarrett	3623	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East - EP, JP, US see attached search strategy	3/21/2006	SJ
Google.com see attached search strategy	3/21/2006	SJ
ProQuest see attached search strategy	3/21/2006	SJ
Dialog see attached search history	3/21/2006	SJ